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EXAMINER

CHEN, JACK S J

ART UNIT

PAPER NUMBER

2813

DATE MAILED: 10/03/2003

Please find below and/or attached an Office communication concerning this application or proceeding.

# Office Action Summary

Application No.

10/052,853

Applicant(s)

WADA ET AL.

Examiner

Jack Chen

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-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

## Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133).
- Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

## Status

- 1) ☒ Responsive to communication(s) filed on 29 April 2003.
- 2a) ☐ This action is FINAL. 2b) ☒ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

## Disposition of Claims

- 4) ☒ Claim(s) 9-15 is/are pending in the application.
- 4a) Of the above claim(s) \_\_\_\_\_ is/are withdrawn from consideration.
- 5) ☐ Claim(s) \_\_\_\_\_ is/are allowed.
- 6) ☒ Claim(s) 9-15 is/are rejected.
- 7) ☐ Claim(s) \_\_\_\_\_ is/are objected to.
- 8) ☐ Claim(s) \_\_\_\_\_ are subject to restriction and/or election requirement.

## Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☒ The drawing(s) filed on 09 November 2001 is/are: a) ☐ accepted or b) ☒ objected to by the Examiner.
- Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
- 11) ☐ The proposed drawing correction filed on \_\_\_\_\_ is: a) ☐ approved b) ☐ disapproved by the Examiner.
- If approved, corrected drawings are required in reply to this Office action.
- 12) ☐ The oath or declaration is objected to by the Examiner.

## Priority under 35 U.S.C. §§ 119 and 120

- 13) ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☐ All b) ☐ Some \* c) ☐ None of:
1. ☐ Certified copies of the priority documents have been received.
2. ☐ Certified copies of the priority documents have been received in Application No. \_\_\_\_\_.
3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).
- \* See the attached detailed Office action for a list of the certified copies not received.
- 14) ☐ Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application).
- a) ☐ The translation of the foreign language provisional application has been received.
- 15) ☒ Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121.

## Attachment(s)

- 1) ☒ Notice of References Cited (PTO-892)
- 2) ☐ Notice of Draftsperson's Patent Drawing Review (PTO-948)
- 3) ☐ Information Disclosure Statement(s) (PTO-1449) Paper No(s) \_\_\_\_\_
- 4) ☐ Interview Summary (PTO-413) Paper No(s). \_\_\_\_\_
- 5) ☐ Notice of Informal Patent Application (PTO-152)
- 6) ☐ Other: \_\_\_\_\_

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### DETAILED ACTION

1. In response to the communications dated April 29, 2003, claims 9-15 are active in this application.

2. In view of the appeal brief filed on April 29, 2003, PROSECUTION IS HEREBY REOPENED. The rejections are set forth below.

To avoid abandonment of the application, appellant must exercise one of the following two options:

(1) file a reply under 37 CFR 1.111 (if this Office action is non-final) or a reply under 37 CFR 1.113 (if this Office action is final); or,

(2) request reinstatement of the appeal.

If reinstatement of the appeal is requested, such request must be accompanied by a supplemental appeal brief, but no new amendments, affidavits (37 CFR 1.130, 1.131 or 1.132) or other evidence are permitted. See 37 CFR 1.193(b)(2).

### *Drawings*

3. The drawings are objected to under 37 CFR 1.83(a). **The drawings must show every feature of the invention specified in the claims.** Therefore, *the passivation layer covering the flash memory cell* (Re claim 9) must be shown or the feature(s) canceled from the claim(s). No new matter should be entered.

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A proposed drawing correction or corrected drawings are required in reply to the Office action to avoid abandonment of the application. The objection to the drawings will not be held in abeyance.

4. The drawings are objected to under 37 CFR 1.83(a). **The drawings must show every feature of the invention specified in the claims.** Therefore, the floating gate (Re claim 9) must be shown or the feature(s) canceled from the claim(s). No new matter should be entered.

A proposed drawing correction or corrected drawings are required in reply to the Office action to avoid abandonment of the application. The objection to the drawings will not be held in abeyance.

***Claim Rejections - 35 USC § 112***

5. The following is a quotation of the first paragraph of 35 U.S.C. 112:

The specification shall contain a written description of the invention, and of the manner and process of making and using it, in such full, clear, concise, and exact terms as to enable any person skilled in the art to which it pertains, or with which it is most nearly connected, to make and use the same and shall set forth the best mode contemplated by the inventor of carrying out his invention.

6. Claims 9-15 are rejected under 35 U.S.C. 112, first paragraph, as containing subject matter which was not described in the specification in such a way as to enable one skilled in the art to which it pertains, or with which it is most nearly connected, to make and/or use the invention. Re claim 9, the phrase “the passivation layer covering the flash memory cell” is not supported by the original disclosure.

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***Claim Rejections - 35 USC § 102***

7. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

8. Claims 9-10 and 15 are rejected under 35 U.S.C. 102(b) as being anticipated by Shirota et al., U.S./5,519,246.

Shirota et al. disclose a nonvolatile memory (inherently shows the device including flash memory since flash memory is a type of nonvolatile memory device) comprising a semiconductor substrate 9 that includes a flash memory cell that has a floating gate 6 (fig. 3); a conductive layer 2 (i.e., Al) formed on the substrate (fig. 3); and a passivation layer (in this case, both layers 1 and 3) formed on the conductive layer that is not transparent to ultraviolet light (fig. 3, see abstract section), the passivation layer covering the flash memory cell (fig. 3), see figs. 1-4 and cols. 1-4 for more details.

Re claim 10, wherein the passivation layer comprises a barrier layer 3 (in this case, layer 3 is considered as the barrier) and a stress reduction layer 1 (polyimide), see fig. 3.

Re claim 15, wherein the passivation layer comprises a polyimide layer 1 (fig. 3).

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***Claim Rejections - 35 USC § 103***

9. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation under 37 CFR 1.56 to point out the inventor and invention dates of each claim that was not commonly owned at the time a later invention was made in order for the examiner to consider the applicability of 35 U.S.C. 103© and potential 35 U.S.C. 102(e), (f) or (g) prior art under 35 U.S.C. 103(a).

10. Claim 11 is rejected under 35 U.S.C. 103(a) as being unpatentable over Shirota et al., U.S./5,519,246 in view of Kiyohiko [JPO Publication Number: 04-078,173].

Shirota et al. disclosed in above paragraph 8; however, Shirota et al. is silent to using the specific material, such as *silicon nitride* in combination with the polyimide.

Kiyohiko discloses a nonvolatile memory (called "EPROM" in Kiyohiko, English abstract section, lines 1-4) comprising: a semiconductor substrate 1 (fig. 1) that includes a flash memory cell (called "EPROM element" in Kiyohiko, English abstract section, lines 1-4) that has a floating gate 3 (fig. 1, English abstract section, lines 10); a conductive layer 7 (fig. 1, called "aluminum

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wiring” in Kiyohiko, English abstract section, line 8) formed on the substrate 1; and a passivation layer 9 and 10 (fig. 1, English abstract section, lines 5-6, *wherein the passivation layer comprises a silicon nitride layer 9 and a polyimide layer 10*) formed on the conductive layer 7 that is not transparent to ultraviolet light (called “opaque to ultraviolet rays” in Kiyohiko, English abstract section, line 9).

Therefore, it would have been obvious to one having ordinary skill in the art at the time the invention was made to using silicon nitride in combination with polyimide for the passivation layer as taught by Kiyohiko in the device of Shirota et al. in order to prevent a direct contact between the polyimide film and Al film.

11. Claims 12-14 are rejected under 35 U.S.C. 103(a) as being unpatentable over Shirota et al., U.S./5,519,246 in view of Kiyohiko [JPO Publication Number: 04-078,173] as applied to claim 11 above, and further in view of Jeuch [U.S. Patent Number: 5,138,573].

Shirota et al. disclosed above in paragraph 8, in particular, the device comprises a floating gate 6 having the physical gate length as shown in fig. 3; however, Shirota et al. is silent to the floating gate having a length that is less than about 0.5 microns.

Jeuch teaches a EPROM (col. 1, lines 5-10) comprising a floating gate (col. 2, lines 49-53) having a length (called “width” in Jeuch, col. 2, lines 49-50) that is less than 0.5 microns (col. 2, lines 49-53 and col. 3, lines 44-50), which greatly contributes to reducing the dimensions of the storage cell (col. 2, lines 49-53).

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Regarding claim 13, Shirota et al. shows the conductive layer forms the final metal interconnect 2 (fig. 3) for the flash memory, upon which is formed the passivation layer 1 and 3 (fig. 3).

Regarding claim 14, Kiyohiko shows the silicon nitride layer 9 (fig. 1) is about  $0.3\text{ }\mu\text{m}$  (page 466, left column, lines 1-3, which corresponds to *3000 angstroms* ) thick.

Therefore, it would have been obvious to one having ordinary skill in the art at the time the invention was made to modify the device structure of Shirota et al. and Kiyohiko by selecting the suitable floating gate length as taught by Jeuch in order to reduce the dimensions of the storage cell (col. 2, lines 49-53), such will reduce the dimensions of the integrated circuits and increase the integration density (col. 1, lines 27-30). Further in this regard, it has been held that discovering an optimum value of a result effective variable involves only routine skill in the art. *In re Boesch*, 617 F.2d 272, 205 USPQ 215 (CCPA 1980).

### ***Conclusion***

12. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Jack Chen whose telephone number is (703) 308-5838. The examiner can normally be reached on Monday-Friday (alternate Monday off) from 8:30 am to 6:00 pm.



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If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Carl Whitehead, Jr., can be reached on (703)308-4940. The fax phone numbers for the organization where this application or proceeding is assigned are 703-872-9318 for regular communications and 703-872-9319 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703)308-0956.

A handwritten signature in black ink, appearing to read 'Jack Chen', with a long horizontal flourish extending to the right.

Jack Chen

Primary Examiner

September 22, 2003